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APPROVAL SHEET

Approval Specification	Customer's Approval Certificate			
TO:	Please return this copy as a certification of your approval			
Part No.:	Checked & Approved by:			
Customer's Part No.:	Date:			

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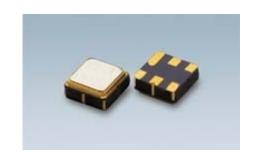
Part No.	:	R433F
Pages	:	6
Date	:	2013/4/22
Revision	:	1.0



Prepared by:	
Checked by:	
Approved by:	

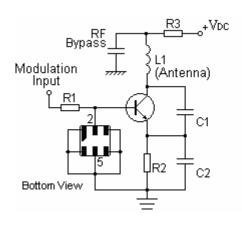
Features

- 1-port Resonator
- Ceramic Package for Surface Mounted Technology (SMT)
- RoHS compatible
- Package size 3.80x3.80x1.50mm³
- Package Code DCC6
- Electrostatic Sensitive Device(ESD)

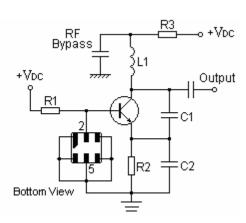


Application

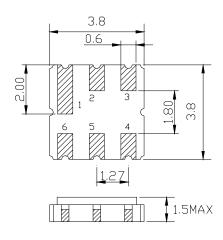
Typical Low-Power Transmitter Application



Typical Local Oscillator Application

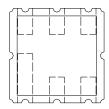


Package Dimensions (DCC6)

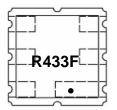


Pin Configuration

2	Input	
5	Output	
1,3,4,6	Ground	

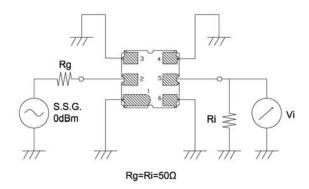


Marking

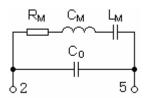


R	SAW Resonator
433F	Part number

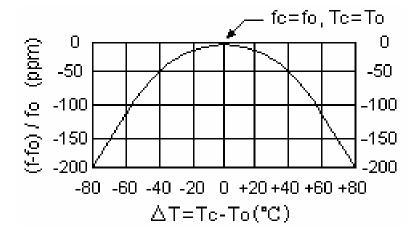
Test Circuit



Equivalent LC Model



Temperature Characteristics



The curve shown above accounts for resonator contribution only and does not include LC component temperature contributions.

Performance

Maximum Rating

Item		Value	Unit
DC Voltage	V_{DC}	10	V
Operation Temperature	Т	-40 ~ +85	$^{\circ}$
Storage Temperature	T _{stg}	-55 ~ +125	$^{\circ}$
RF Power Dissipation	Р	10	dBm

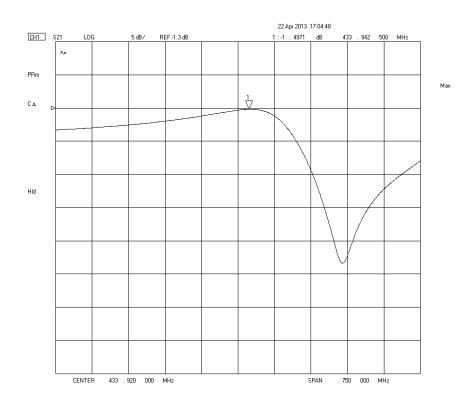
Electronic Characteristics

Test Temperature: $25^{\circ}C \pm 2^{\circ}C$

Terminating source impedance: 50Ω Terminating load impedance: 50Ω

Item			Minimum	Typical	Maximum	Unit
Center	Absolute Frequency	fc		433.920		MHz
Frequency	Tolerance from 433.920MHz	△f _c		±75		KHz
Insertion Loss(r	nin)	IL		1.6	2.0	dB
Quality Factor	Unloaded Q	Q _U		12451		
Quality Factor	50Ω Loaded Q	Q _L		1984		
	Turnover Temperature	T ₀	25	40	55	$^{\circ}$
Temperature Stability	Turnover Frequency	f ₀		f _c		
	Frequency Temperature Coefficient	FTC		0.032		ppm/℃
Frequency Aging Absolute Value during the First Year		f _A		≤10		ppm/yr
DC Insulation Resistance between Any Two Pins			1.0			$M\Omega$
	Motional Resistance	R _M		19.5	25.5	Ω
RF Equivalent RLC Model	Motional Inductance	L _M		86.6	95.8	μΗ
	Motional Capacitance	См		1.55		fF
	Static Capacitance	C ₀	1.80	2.25	2.80	pF

Frequency Response

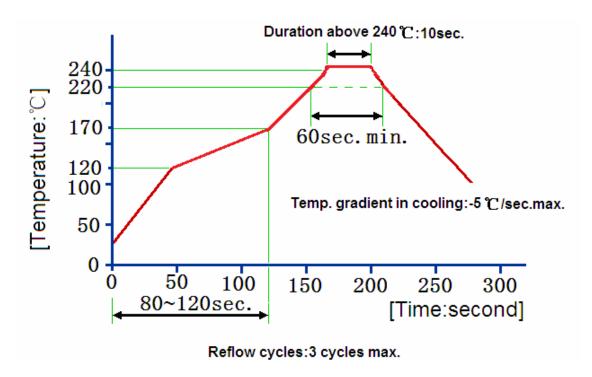


Reliability (The SAW components shall remain electrical performance after tests)

No.	Test item	Test condition
1	Temperature Storage	(1) Temperature: 85℃±2℃, Duration: 250h, Recovery time: 2h±0.5h (2) Temperature: -55℃±3℃, Duration: 250h, Recovery time: 2h±0.5h
2	Humidity Test	Conditions: 60℃±2℃ , 90~95% RH
3	Thermal Shock	Heat cycle conditions: TA=-40℃±3℃, TB=85℃±2℃, t1=t2=30min, Switch time: ≤3min , Cycle time: 100 times , Recovery time : 2h±0.5h.
4	Vibration Fatigue	Frequency of vibration: 10~55Hz Amplitude:1.5mm Directions: X,Y and Z Duration: 2h
5	Drop Test	Cycle time: 10 times Height: 1.0m
6	Solder Ability Test	Temperature: 245℃±5℃ Duration: 3.0s5.0s Depth: DIP2/3 , SMD1/5
7	Resistance to Soldering Heat	(1)Thickness of PCB:1mm , Solder condition: 260℃±5℃ , Duration: 10±1s (2)Temperature of Soldering Iron: 350℃±10℃ , Duration: 3~4s , Recovery time : 2 ± 0.5h

- 5 -

Recommended Reflow Soldering Diagram



Notes

- 1. As a result of the particularity of inner structure of SAW products, it easy to be breakdown by electrostatic, so we should pay attention to **ESD protect** in the test.
- 2. **Static voltage** between signal load and ground may cause deterioration and destruction of the component. Please avoid static voltage.
- 3. **Ultrasonic cleaning** may cause deterioration and destruction of the component. Please avoid ultrasonic cleaning.

- 6 -

- 4. Only leads of component may **be soldered**. Please avoid soldering another part of component.
- 5. There is a close relationship between the device's performance and **matching network**. The specifications of this device are based on the test circuit shown above. L and C values may change depending on board layout. Values shown are intended as a guide only.